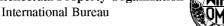
(19) World Intellectual Property Organization







(43) International Publication Date 15 December 2005 (15.12.2005)

(10) International Publication Number WO 2005/119365 A3

(51) International Patent Classification: **G03F 7/20** (2006.01) G21K 1/06 (2006.01)

(21) International Application Number:

PCT/US2005/019486

(22) International Filing Date: 1 June 2005 (01.06.2005)

(25) Filing Language: English

(26) Publication Language: English

(30) Priority Data:

10/862,127

2 June 2004 (02.06.2004)

- (71) Applicant (for all designated States except US): THE REGENTS OF THE UNIVERSITY OF CALIFORNIA [US/US]; 1111 Franklin Street, Oakland, CA 94607-5200 (US).
- (72) Inventor; and
- (75) Inventor/Applicant (for US only): CHAPMAN, Henry, N. [US/US]; 1312 Melanie Way, Livermore, CA 94550
- (74) Agent: THOMPSON, Alan, H.; P.O. Box 808, L-703, Livermore, CA 94550 (US).

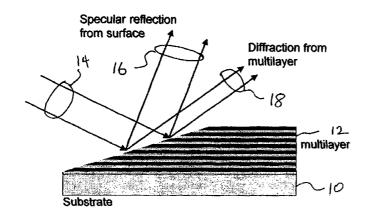
- (81) Designated States (unless otherwise indicated, for every kind of national protection available): AE, AG, AL, AM, AT, AU, AZ, BA, BB, BG, BR, BW, BY, BZ, CA, CH, CN, CO, CR, CU, CZ, DE, DK, DM, DZ, EC, EE, EG, ES, FI, GB, GD, GE, GH, GM, HR, HU, ID, IL, IN, IS, JP, KE, KG, KM, KP, KR, KZ, LC, LK, LR, LS, LT, LU, LV, MA, MD, MG, MK, MN, MW, MX, MZ, NA, NG, NI, NO, NZ, OM, PG, PH, PL, PT, RO, RU, SC, SD, SE, SG, SK, SL, SM, SY, TJ, TM, TN, TR, TT, TZ, UA, UG, US, UZ, VC, VN, YU, ZA, ZM, ZW.
- (84) Designated States (unless otherwise indicated, for every kind of regional protection available): ARIPO (BW, GH, GM, KE, LS, MW, MZ, NA, SD, SL, SZ, TZ, UG, ZM, ZW), Eurasian (AM, AZ, BY, KG, KZ, MD, RU, TJ, TM), European (AT, BE, BG, CH, CY, CZ, DE, DK, EE, ES, FI, FR, GB, GR, HU, IE, IS, IT, LT, LU, MC, NL, PL, PT, RO, SE, SI, SK, TR), OAPI (BF, BJ, CF, CG, CI, CM, GA, GN, GQ, GW, ML, MR, NE, SN, TD, TG).

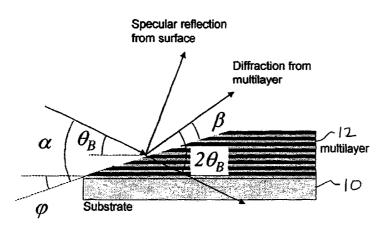
Published:

with international search report

[Continued on next page]

(54) Title: A HIGH-EFFICIENCY SPECTRAL PURITY FILTER FOR EUV LITHOGRAPHY





(57) Abstract: An asymmetric-cut multilayer diffracts EUV light. A multilayer cut at an angle has the same properties as a blazed grating, and has been demonstrated to have near-perfect performance. Instead of having to nano-fabricate a grating structure with imperfections no greater than several tens of nanometers, a thick multilayer is grown on a substrate and then cut at an inclined angle using coarse and inexpensive methods. Effective grating periods can be produced this way that are 10 to 100 times smaller than those produced today, and the diffraction efficiency of these asymmetric multilavers is higher than conventional gratings. Besides their ease of manufacture, the use of an asymmetric multilayer as a spectral purity filter does not require that the design of an EUV optical system be modified in any way, unlike the proposed use of blazed gratings for such systems.

(88) Date of publication of the international search report: 2 March 2006

For two-letter codes and other abbreviations, refer to the "Guidance Notes on Codes and Abbreviations" appearing at the beginning of each regular issue of the PCT Gazette.

INTERNATIONAL SEARCH REPORT

Internation pplication No

PCT/US2005/019486 A. CLASSIFICATION OF SUBJECT MATTER G03F7/20 G21K G21K1/06 According to International Patent Classification (IPC) or to both national classification and IPC B. FIELDS SEARCHED Minimum documentation searched (classification system followed by classification symbols) G03F G21K Documentation searched other than minimum documentation to the extent that such documents are included, in the fields searched Electronic data base consulted during the international search (name of data base and, where practical, search terms used) EPO-Internal, PAJ, INSPEC C. DOCUMENTS CONSIDERED TO BE RELEVANT Category ° Citation of document, with indication, where appropriate, of the relevant passages Relevant to claim No. Υ US 5 848 119 A (MIYAKE ET AL) 1 - 88 December 1998 (1998-12-08) column 2, lines 61-67 column 3, lines 41-51 column 6, lines 18-27 claim 3 Υ LEVASHOV V E ET AL: "High throughput and 1-8 resolution compact spectrograph for the 124-250 A range based on MoSi2-Si sliced multilayer grating" OPTICS COMMUNICATIONS NETHERLANDS, vol. 109, no. 1-2, 15 June 1994 (1994-06-15), pages 1-4, XP002354621 the whole document -/--Further documents are listed in the continuation of box C. Patent family members are listed in annex. ° Special categories of cited documents: *T* later document published after the international filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the *A* document defining the general state of the art which is not considered to be of particular relevance invention "E" earlier document but published on or after the international *X* document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to filing date "L" document which may throw doubts on priority claim(s) or which is cited to establish the publication date of another involve an inventive step when the document is taken alone "Y" document of particular relevance; the claimed invention citation or other special reason (as specified) cannot be considered to involve an inventive step when the document is combined with one or more other such docu-"O" document referring to an oral disclosure, use, exhibition or ments, such combination being obvious to a person skilled other means *P* document published prior to the international filing date but later than the priority date claimed "&" document member of the same patent family Date of the actual completion of the international search Date of mailing of the international search report 17 November 2005 30/11/2005 Name and mailing address of the ISA Authorized officer European Patent Office, P.B. 5818 Patentlaan 2 NL - 2280 HV Rijswijk Tel. (+31-70) 340-2040, Tx. 31 651 epo nl,

Eisner, K

Fax: (+31-70) 340-3016

INTERNATIONAL SEARCH REPORT

Internation—nplication No
PCT/US2005/019486

C.(Continuation) DOCUMENTS CONSIDERED TO BE RELEVANT									
Category °	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.							
		Relevant to claim No.							

INTERNATIONAL SEARCH REPORT

Information on patent family members

Internation pplication No PCT/US2005/019486

Patent document cited in search report		Publication date	Patent family member(s)		Publication date
US 5848119	Α	08-12-1998	JP JP	3167095 B2 9021900 A	14-05-2001 21-01-1997
US 5287395	Α	15-02-1994	NONE		